

# MOS FIELD EFFECT TRANSISTOR **2SK3570**

# SWITCHING N-CHANNEL POWER MOS FET

#### DESCRIPTION

The 2SK3570 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

#### FEATURES

•4.5V drive available.
•Low on-state resistance, R<sub>DS(on)1</sub> = 12 mΩ MAX. (V<sub>GS</sub> = 10 V, I<sub>D</sub> = 24 A)
•Low gate charge Q<sub>G</sub> = 23 nC TYP. (V<sub>DD</sub> = 16 V, V<sub>GS</sub> = 10 V, I<sub>D</sub> = 48 A)
•Built-in gate protection diode
•Surface mount device available

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (V <sub>GS</sub> = 0 V)	VDSS	20	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±48	А
Drain Current (pulse) Note	D(pulse)	±160	А
Total Power Dissipation ( $T_A = 25^{\circ}C$ )	<b>P</b> T1	1.5	W
Total Power Dissipation (Tc = $25^{\circ}$ C)	P <sub>T2</sub>	29	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
<b>Note</b> PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1%			

#### **\*** ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3570	TO-220AB
2SK3570-S	TO-262
2SK3570-ZK	TO-263
2SK3570-Z	TO-220SMD Note

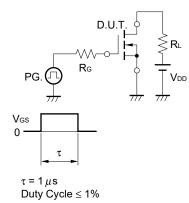
Note TO-220SMD package is produced only in Japan.

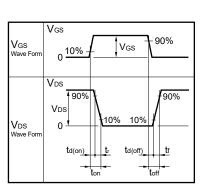
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Characteristics	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			10	μA
Gate Leakage Current	lgss	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5		2.5	V
Forward Transfer Admittance	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 24 A	8.0			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Id = 24 A		8.2	12	mΩ
	RDS(on)2	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 15 A		12.3	22	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		930		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		360		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		250		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 24 A		13		ns
Rise Time	tr	V <sub>G</sub> s = 10 V		20		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 10 Ω		39		ns
Fall Time	tr			14		ns
Total Gate Charge	QG	V <sub>DD</sub> = 16 V		23		nC
Gate to Source Charge	Q <sub>GS</sub>	V <sub>G</sub> s = 10 V		4		nC
Gate to Drain Charge	Qgd	I <sub>D</sub> = 48 A		7		nC
Body Diode Forward Voltage	V <sub>F(S-D)</sub>	IF = 48 A, VGS = 0 V		1.1		V
Reverse Recovery Time	trr	IF = 48 A, VGS = 0 V		33		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		25		nC

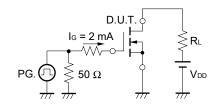
## ELECTRICAL CHARACTERISTICS (TA = 25°C)

### ★ TEST CIRCUIT 1 SWITCHING TIME

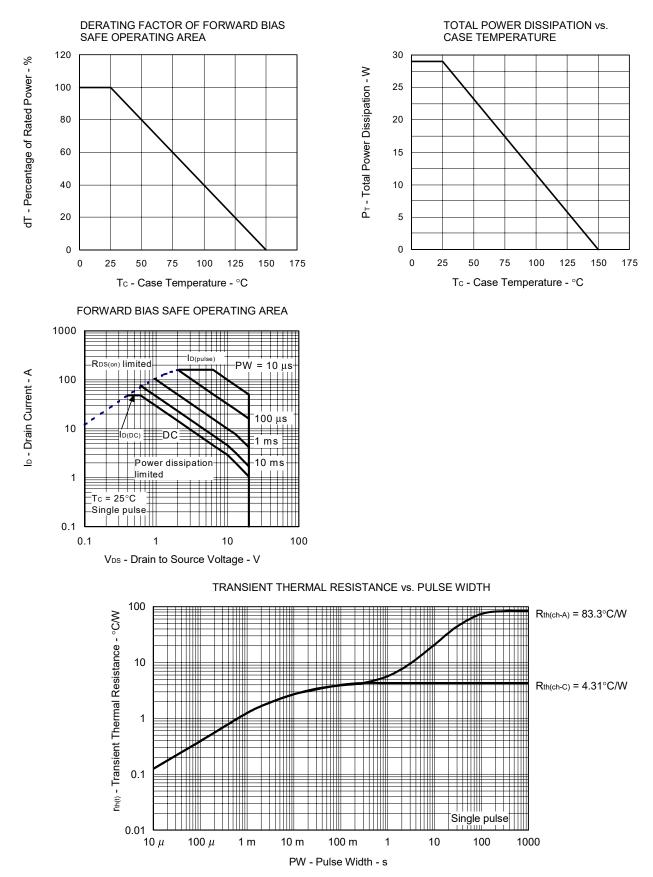


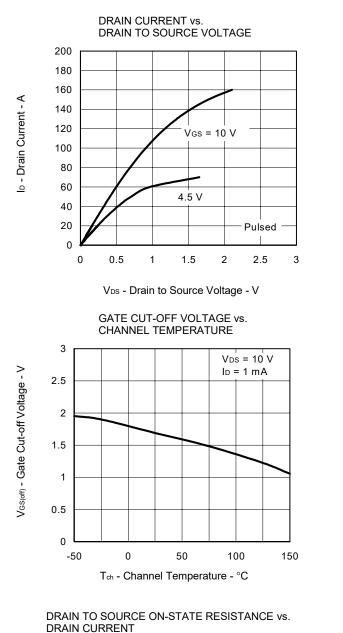


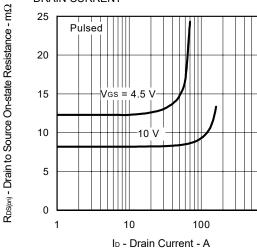
#### TEST CIRCUIT 2 GATE CHARGE



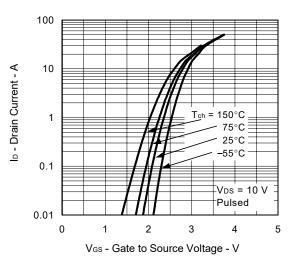
#### **\* TYPICAL CHARACTERISTICS (TA = 25^{\circ}C)**







FORWARD TRANSFER CHARACTERISTICS

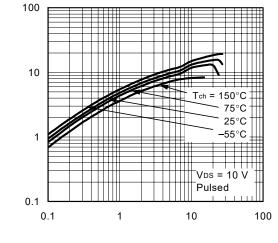


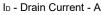
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

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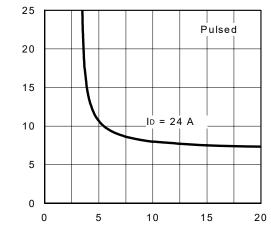
| y<sub>fs</sub> | - Forward Transfer Admittance .

 $R_{\text{DS(on)}}$  - Drain to Source On-state Resistance -  $m\Omega$ 



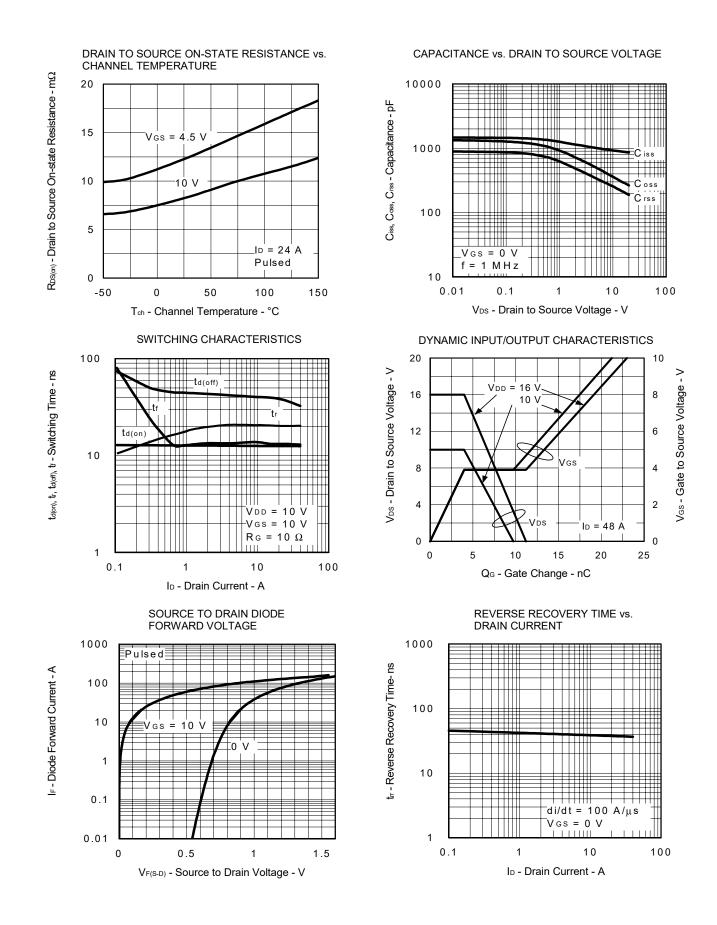


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



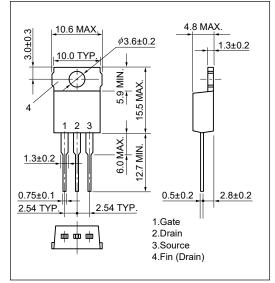
VGS - Gate to Source Voltage - V

1000

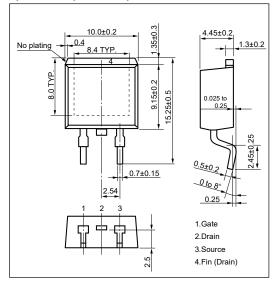


#### \* PACKAGE DRAWINGS (Unit: mm)

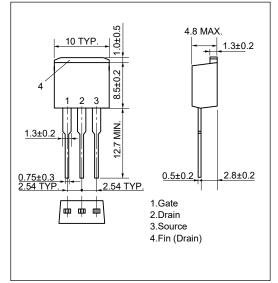
#### 1) TO-220AB (MP-25)



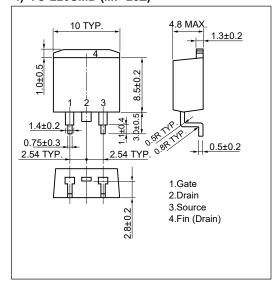
#### 3) TO-263 (MP-25ZK)



#### 2) TO-262 (MP-25 Fin Cut)

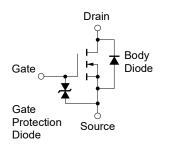


4) TO-220SMD (MP-25Z) Note



Note This package is produced only in Japan.

#### EQUIVALENT CIRCUIT



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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